

Carbon dioxide gas, CO₂(g), by near-ambient pressure XPS

Tahereh G. Avval, Shiladitya Chatterjee, Stephan Bahr, Paul Dietrich, Michael Meyer, Andreas Thißen, and Matthew R. Linford

Citation: [Surface Science Spectra](#) **26**, 014022 (2019); doi: 10.1116/1.5053761

View online: <https://doi.org/10.1116/1.5053761>

View Table of Contents: <https://avs.scitation.org/toc/sss/26/1>

Published by the [American Vacuum Society](#)



Instruments for Advanced Science

Contact Hiden Analytical for further details:

W www.HidenAnalytical.com
E info@hiden.co.uk

CLICK TO VIEW our product catalogue



Gas Analysis

- dynamic measurement of reaction gas streams
- catalysis and thermal analysis
- molecular beam studies
- dissolved species probes
- fermentation, environmental and ecological studies



Surface Science

- UHV-TPD
- SIMS
- end point detection in ion beam etch
- elemental imaging - surface mapping



Plasma Diagnostics

- plasma source characterization
- etch and deposition process reaction kinetic studies
- analysis of neutral and radical species



Vacuum Analysis

- partial pressure measurement and control of process gases
- reactive sputter process control
- vacuum diagnostics
- vacuum coating process monitoring



Carbon dioxide gas, CO₂(g), by near-ambient pressure XPS

Tahereh G. Avval,¹ Shiladitya Chatterjee,¹ Stephan Bahr,² Paul Dietrich,² Michael Meyer,² Andreas Thißen,² and Matthew R. Linford^{1,a)}

¹Department of Chemistry and Biochemistry, Brigham Young University, C100 BNSN, Provo, Utah 84602

²SPECS Surface Nano Analysis GmbH, Voltastrasse 5, 13355 Berlin, Germany

(Received 25 August 2018; accepted 21 May 2019; published 16 July 2019)

Near-ambient pressure x-ray photoelectron spectroscopy (NAP-XPS) is a less traditional form of XPS that allows samples to be analyzed at relatively high pressures, i.e., at greater than 2500 Pa. With NAP-XPS, XPS can probe moderately volatile liquids, biological samples, porous materials, and/or polymeric materials that outgas significantly. In this submission, we show the survey, O 1s, C 1s, valence band, O *KLL* Auger, and C *KLL* Auger NAP-XPS spectra of gaseous carbon dioxide, CO₂, a material that would be difficult to analyze by conventional XPS. A small N 1s signal from N₂(g) is also observed in the survey spectrum. The C 1s and O 1s signals in the narrow scans are fit to Gaussian–Lorentzian sum and asymmetric Lorentzian (LA) functions. Better fits are obtained with the LA synthetic line shape. Since it is likely that CO₂(g) will be present in other NAP-XPS analyses, these data should serve as a useful reference for other researchers. *Published by the AVS.*

<https://doi.org/10.1116/1.5053761>

Keywords: near-ambient pressure X-ray photoelectron spectroscopy, NAP-XPS, XPS, carbon dioxide, CO₂(g)

Accession #: 01486

Technique: XPS, XAES

Host Material: Carbon dioxide, CO₂(g)

Instrument: SPECS EnviroESCA

Major Elements in Spectra: O, C

Minor Elements in Spectra: N

Published Spectra: 6

Spectra in Electronic Record: 6

Spectral Category: Comparison

INTRODUCTION

Carbon dioxide, CO₂, is a colorless, odorless gas that is present in the earth's atmosphere at trace levels. It is produced by combustion (oxidation) of carbon-containing materials, e.g., the oxidation of methanol (Refs. 1 and 2), fermentation, and animal respiration. CO₂ is a major greenhouse gas because of its ability to absorb radiant energy. CO₂ conversion into fuels in the presence of metal catalysts is important for the reduction of environmental pollution (Ref. 3), and near-ambient pressure x-ray photoelectron spectroscopy (NAP-XPS) is well suited for understanding surface reactions of metallic catalysts during CO₂ hydrogenation (Refs. 4 and 5). CO₂ has previously been characterized in the solid state, as a pure ultrathin film (Refs. 6 and 7), and in combination with water and methanol by conventional XPS (Ref. 8). In this submission, we present the NAP-XPS characterization of carbon dioxide, CO₂. Because CO₂ has both theoretical and industrial importance, it is likely that its spectrum will end up superimposed on that of other materials in NAP-XPS analyses—we expect the spectra reported here to be useful references. Data were collected with the SPECS EnviroESCA instrument (Refs. 9–12). This document is part of a series of submissions on NAP-XPS that is being submitted to Surface Science Spectra. This set of articles and the NAP-XPS technique have previously been introduced in this journal (Ref. 13).

This submission contains the survey, O 1s, C 1s, valence band, O *KLL* Auger, and C *KLL* Auger NAP-XPS spectra of gas phase CO₂. A small N 1s signal from N₂(g) is also present in the survey spectrum. The O 1s narrow scan shows a main peak at a binding energy of ca. 537 eV from CO₂. The other two small peaks/groups of peaks at binding energies of ca. 550 and 554 eV are shake-up peaks (the C 1s narrow scan that is described below shows similar shake-up signals) (Refs. 1 and 14). The C Auger signal in the survey spectrum is barely discernible.

This may be a combination of the fact that this signal is generally much smaller than C 1s signal and also that there may be greater attenuation of the signal at higher binding energy (lower kinetic energy where the C Auger signal appears) than at lower binding energy (higher kinetic energy where the C 1s signal appears). The C 1s narrow scan primarily shows one signal, which is attributed to carbon in CO₂(g). This signal appears at relatively high binding energy because the carbon in CO₂ is chemically shifted to a rather high oxidation state through four carbon-oxygen bonds (Ref. 15), and also because gas phase photoelectron signals generally appear at higher binding energies than those from condensed phases. The valence band of CO₂(g) is also presented. It has previously been shown and discussed in the literature (Refs. 14 and 16–18). No energy correction was applied to the spectra presented here, which are referenced to the Fermi level of the instrument. The work function of the spectrometer used in this study was 4.4463 eV.

The O 1s and C 1s signals here are fit to Gaussian–Lorentzian sum (GLS) (Ref. 19) and asymmetric Lorentzian (LA) (Ref. 20) functions above flat, linear baselines. These baselines are typical for NAP-XPS spectra because of a lack of inelastically scattered electrons from gas phase materials. These peaks are better fit with LA synthetic line shapes, which suggest that they have a significant amount of Lorentzian character. For the O 1s fit, the GLS had a Lorentzian contribution of 20%, while the LA function had α , β , and m values of 1.7, 2.7, and 0, respectively. The α and β parameters in the LA function are exponents that determine the degree of asymmetry on the lower and higher binding energy sides of the synthetic peak, respectively. The parameter m is a measure of the Gaussian contribution to the LA function vis-à-vis the convolution of a Gaussian with the asymmetric Lorentzian portion of the LA function, i.e., the LA function allows an asymmetric Voigt function to be created. For the C 1s fit, the GLS had a Lorentzian contribution of 20%, while the LA function had α , β , and m values of 1.5, 2.2, and 0, respectively.

^{a)}Electronic mail: mrlniford@chem.byu.edu

SPECIMEN DESCRIPTION (ACCESSION #01486) —

Host Material: Carbon dioxide, CO₂(g)

CAS Registry #: 7732-18-5

Host Material Characteristics: Homogeneous; gas; amorphous; inorganic compound; other

Chemical Name: Carbon dioxide, CO₂(g)

Source: Messer Griesheim GmbH

Host Composition: Carbon dioxide, CO₂(g)

Form: Gas

Structure: CO₂, O=C=O

History and Significance: CO₂ is an important product of the combustion (oxidation) of organic materials and an important greenhouse gas.

As Received Condition: Compressed gas cylinder

Analyzed Region: Carbon dioxide gas molecules encountered by the X-ray beam.

Ex Situ Preparation/Mounting: N/A

In Situ Preparation: N/A

Charge Control: 200 Pa CO₂

Temp. During Analysis: 300 K

Pressure During Analysis: 200 Pa

Prealysis Beam Exposure: 30 s

INSTRUMENT DESCRIPTION —

Manufacturer and Model: SPECS EnviroESCA

Analyzer Type: Spherical sector

Detector: Other 1D delay line detector (1D-DLD)

Number of Detector Elements: 25

INSTRUMENT PARAMETERS COMMON TO ALL SPECTRA —

■ Spectrometer

Analyzer Mode: Constant pass energy

Throughput (T = E^N): N = 0

Excitation Source Window: Silicon nitride

Excitation Source: Al K_α monochromatic

Source Energy: 1486.6 eV

Source Strength: 42 W

Source Beam Size: 250 × 250 μm²

Signal Mode: Multichannel direct

■ Geometry

Incident Angle: 55°

Source-to-Analyzer Angle: 55°

Emission Angle: 0°

Specimen Azimuthal Angle: 0°

Acceptance Angle from Analyzer Axis: 22°

Analyzer Angular Acceptance Width: 44°

DATA ANALYSIS METHOD —

Energy Scale Correction: No correction

Recommended Energy Scale Shift: 0

Peak Shape and Background Method: GLS and also asymmetric Lorentzian (LA) functions were used for peak fitting on top of linear backgrounds. All peak fitting was with CASAXPS (Casa Software Ltd., Version 2.3.18PR1.0).

Quantitation Method: Elemental compositions were calculated using the standard SPECS software.

REFERENCES —

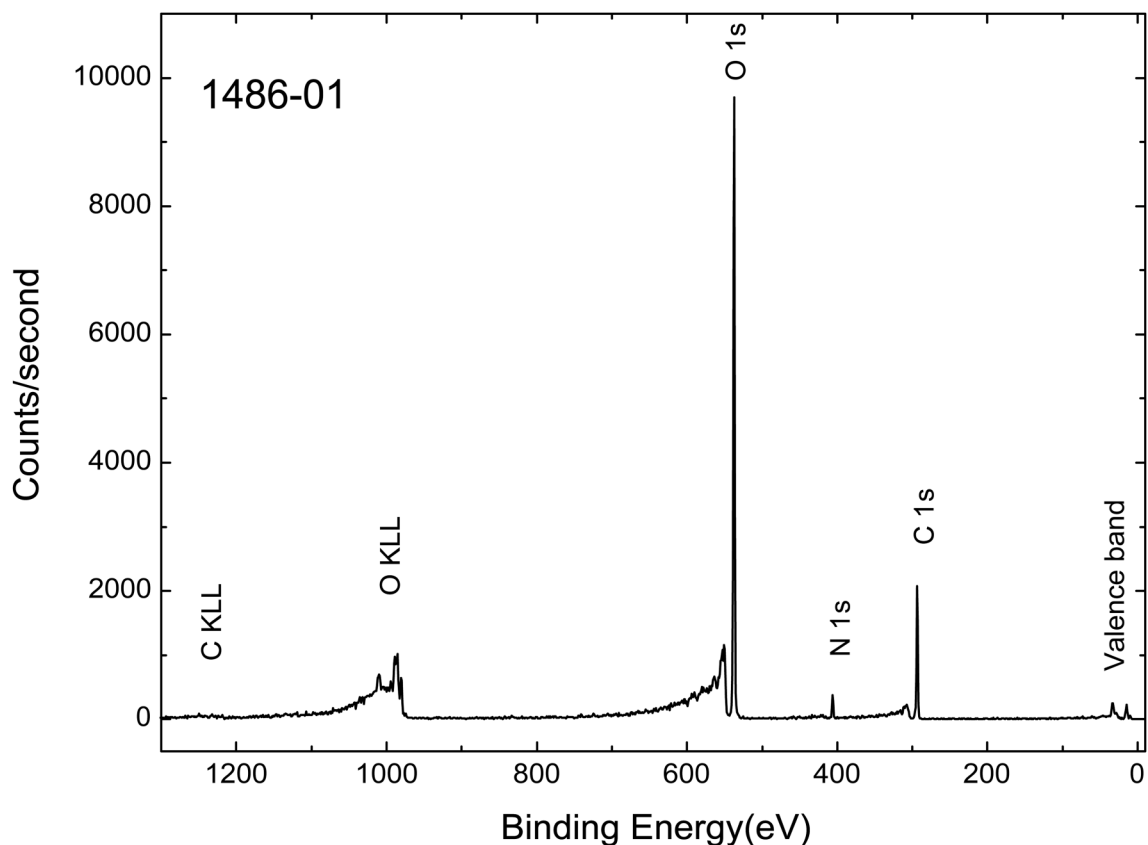
1. I. P. Prosvirin, A. V. Bukhtiyarov, H. Bluhm, and V. I. Bukhtiyarov, *Appl Surf. Sci.* **363**, 303 (2016).
2. H. Bluhm, M. Hävecker, A. Knop-Gericke, E. Kleimenov, R. Schlögl, D. Teschner, V. I. Bukhtiyarov, D. F. Ogletree, and M. Salmeron, *J. Phys. Chem. B* **108**, 14340 (2004).
3. Z. Jiang, T. Xiao, V. Kuznetsov, and P. Edwards, *Phil. Trans. R. Soc. A* **368**, 3343 (2010).
4. A. Sápi *et al.*, *J. Phys. Chem. C* **122**, 5553 (2018).
5. M. Favaro, H. Xiao, T. Cheng, W. A. Goddard, J. Yano, and E. J. Crumlin, *Proc. Natl. Acad. Sci. U.S.A.* **114**, 6706 (2017).
6. T. R. Dillingham, D. M. Cornelison, K. Galle, S. C. Tegler, and B. L. Lutz, *Surf. Sci. Spectra* **4**, 157 (1996).
7. M. Cornelison, T. C. Dillingham, S. Tegler, K. Galle, G. Miller, and B. Lutz, *Astrophys. J.* **505**, 443 (2009).
8. T. Dillingham and D. Cornelison, *Surf. Sci. Spectra* **6**, 146 (1999).
9. M. Kjærvi, K. Schwibbert, P. Dietrich, A. Thissen, and W. E. S. Unger, *Surf. Interface Anal.* **50**, 996 (2018).
10. P. M. Dietrich, S. Bahr, T. Yamamoto, M. Meyer, and A. Thissen, *J. Electron Spectrosc.* **231**, 118 (2019).
11. C. Rodriguez, P. Dietrich, V. Torres-Costa, V. Cebrián, C. Gómez-Abad, A. Díaz, O. Ahumada, and M. N. Silván, *Appl. Surf. Sci.* (2019).
12. J. Rieß, M. Lublow, S. Anders, M. Tasbihi, A. Acharjya, K. Kailasam, A. Thomas, M. Schwarze, and R. Schomäcker, *Photoch. Photobio. Sci.* (2019).
13. D. I. R. Patel *et al.*, "Introduction to near ambient pressure-x-ray photoelectron spectroscopy (NAP-XPS) characterization of various materials," *Surf. Sci. Spectra* (accepted).
14. C. J. Allan, U. Gelius, D. A. Allison, G. Johansson, H. Siegbahn, and K. Siegbahn, *J. Electron Spectrosc. Relat. Phenom.* **1**, 131 (1972).
15. V. Gupta, H. Ganegoda, M. H. Engelhard, J. Terry, and M. R. Linford, *J. Chem. Educ.* **91**, 232 (2014).
16. Q. Tian, J. Yang, Y. Shi, X. Shan, and X. Chen, *J. Chem. Phys.* **136**, 094306 (2012).
17. J. W. D. Connolly, H. Siegbahn, U. Gelius, and C. Nordling, *J. Chem. Phys.* **58**, 4265 (1973).
18. A. Giardini-Guidoni, R. Tiribelli, D. Vinciguerra, R. Camilloni, and G. Stefani, *J. Electron Spectrosc. Relat. Phenom.* **12**, 405 (1977).
19. V. Jain, M. C. Biesinger, and M. R. Linford, *Appl. Surf. Sci.* **447**, 548 (2018).
20. P. Dietrich, A. Thißen, V. Jain, and M. R. Linford, "Argon, by near-ambient pressure XPS," *Surf. Sci. Spectra* (accepted).

SPECTRAL FEATURES TABLE							
Spectrum ID #	Element/Transition	Peak Energy (eV)	Peak Width FWHM (eV)	Peak Area (eV counts/s)	Sensitivity Factor	Concentration (at. %)	Peak Assignment
01486-01	Valence band	0–50	CO ₂ (g)
01486-01	C 1s	293.7	CO ₂ (g)
01486-01	N 1s	405.8	N ₂ (g)
01486-01	O 1s	537.3	CO ₂ (g)
01486-01	O KLL ^a	494.1	CO ₂ (g)
01486-01	C KLL ^a	251.7	CO ₂ (g)
01486-02	O 1s	537.2	0.64	2805	2.48	67.5	CO ₂ (g)
01486-03	C 1s	293.6	0.55	545.0	1.00	32.5	CO ₂ (g)
01486-04	O KLL ^a	494.1	CO ₂ (g)
01486-05	C KLL ^a	247.2	CO ₂ (g)
01486-06	1 π_g	9.6	CO ₂ (g)
01486-06	1 π_u	13.9	CO ₂ (g)
01486-06	3 σ_u	14.1	CO ₂ (g)
01486-06	4 σ_g	15.2	CO ₂ (g)

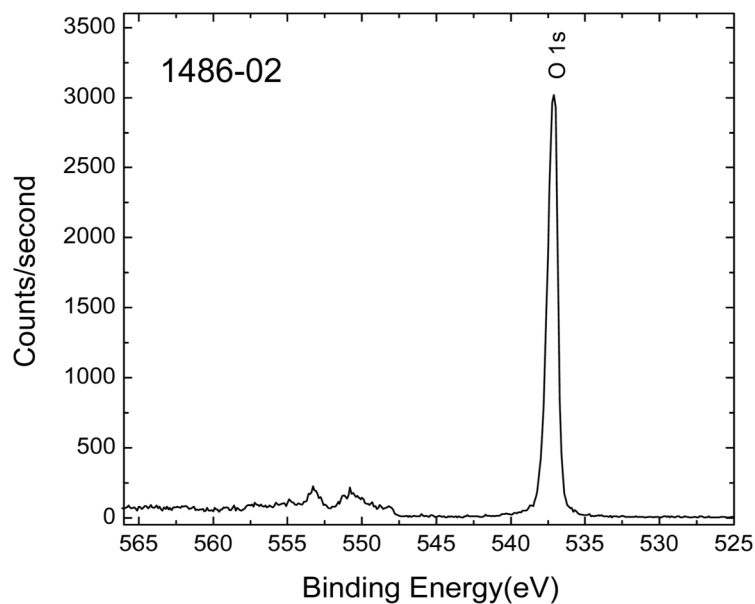
^aPeak energy value indicated as kinetic energy.

ANALYZER CALIBRATION TABLE							
Spectrum ID #	Element/Transition	Peak Energy (eV)	Peak Width FWHM (eV)	Peak Area (eV counts/s)	Sensitivity Factor	Concentration (at. %)	Peak Assignment
...	Au 4f	83.9	0.67	8 940.7
...	Ag 3d	368.1	0.60	13 854.9
...	Ge 2p	1217.5	1.15	8 064.6

GUIDE TO FIGURES						
Spectrum (Accession) #	Spectral Region	Voltage Shift	Multiplier	Baseline	Comment #	
01486-01	Survey	0	1	0	From CO ₂ (g)	
01486-02	O 1s	0	1	0	From CO ₂ (g)	
01486-03	C 1s	0	1	0	From CO ₂ (g)	
01486-04	O KLL	0	1	0	From CO ₂ (g)	
01486-05	C KLL	0	1	0	From CO ₂ (g)	
01486-06	Valence band	0	1	0	From CO ₂ (g)	

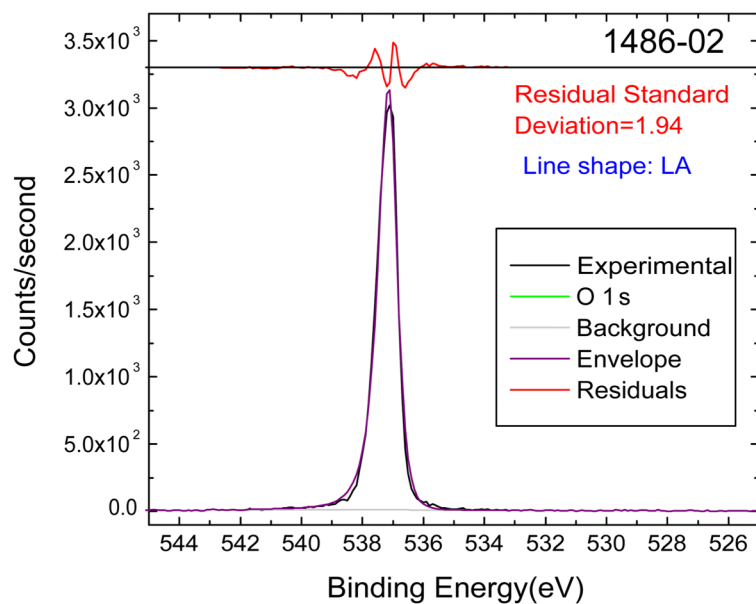
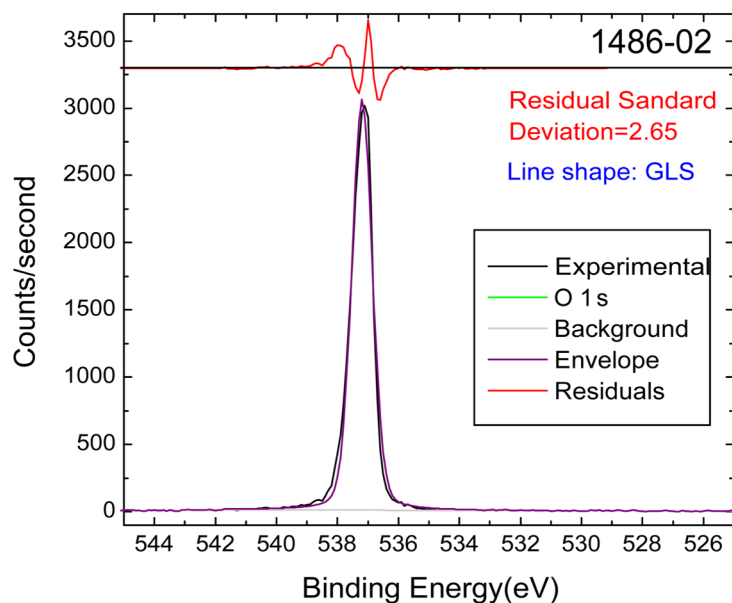


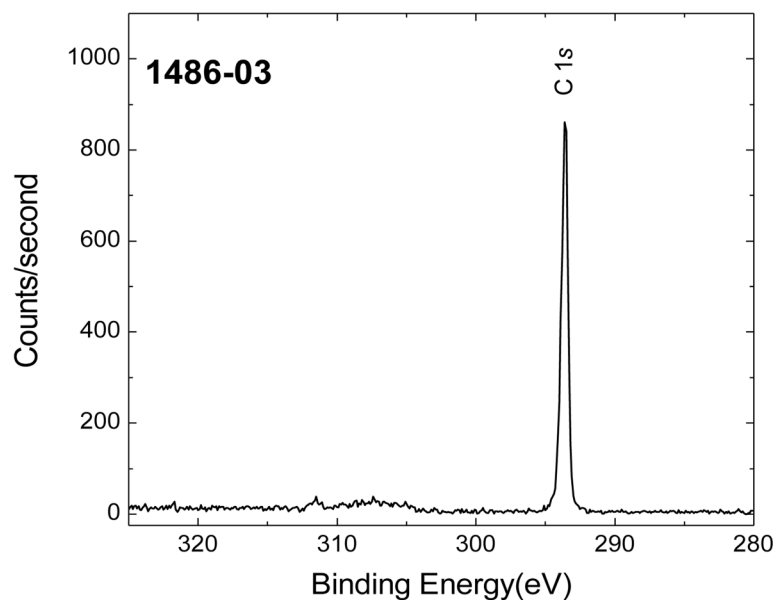
Accession #	01486-01
Host Material:	Carbon dioxide, CO ₂ (g)
Technique:	XPS
Spectral Region:	Survey
Instrument:	SPECS EnviroESCA
Excitation Source:	Al K _α monochromatic
Source Energy:	1486.6 eV
Source Strength:	42 W
Source Size:	0.250 × 0.250 mm ²
Analyzer Type:	Spherical sector analyzer
Incident Angle:	54.7°
Emission Angle:	0°
Analyzer Pass Energy:	100 eV
Analyzer Resolution:	1.7 eV
Total Signal Accumulation Time:	270 s
Total Elapsed Time:	145 s
Number of Scans:	2
Effective Detector Width:	25 eV



■ **Accession #:** 01486-02
 ■ **Host Material:** Carbon dioxide, CO₂(g)
 ■ **Technique:** XPS
 ■ **Spectral Region:** O 1s

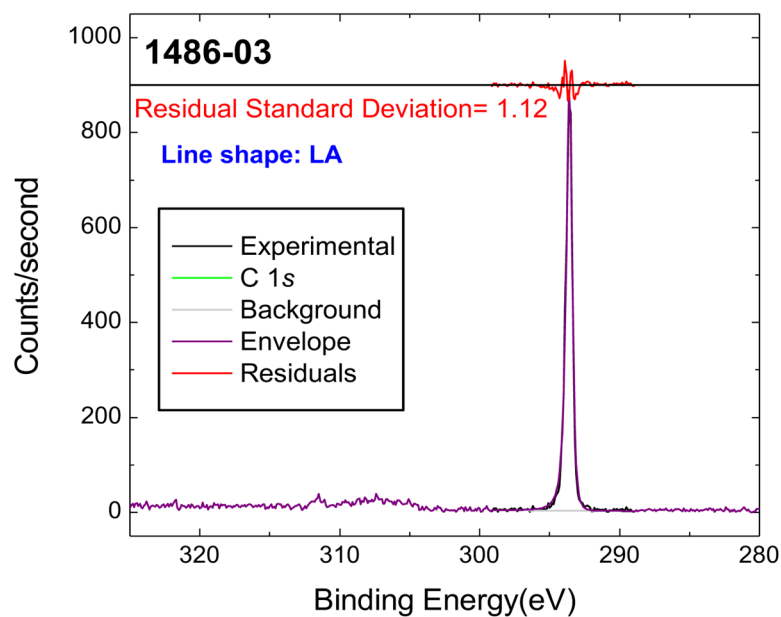
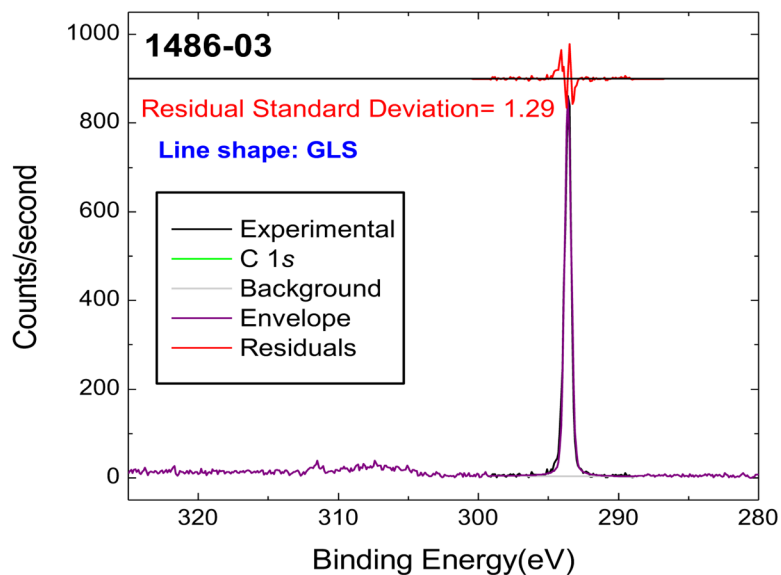
Instrument: SPECS EnviroESCA
 Excitation Source: Al K_α monochromatic
 Source Energy: 1486.6 eV
 Source Strength: 42 W
 Source Size: 0.250 × 0.250 mm²
 Analyzer Type: Spherical sector
 Incident Angle: 54.7°
 Emission Angle: 0°
 Analyzer Pass Energy: 20 eV
 Analyzer Resolution: 0.60 eV
 Total Signal Accumulation Time: 300 s
 Total Elapsed Time: 334 s
 Number of Scans: 3
 Effective Detector Width: 2.5 eV

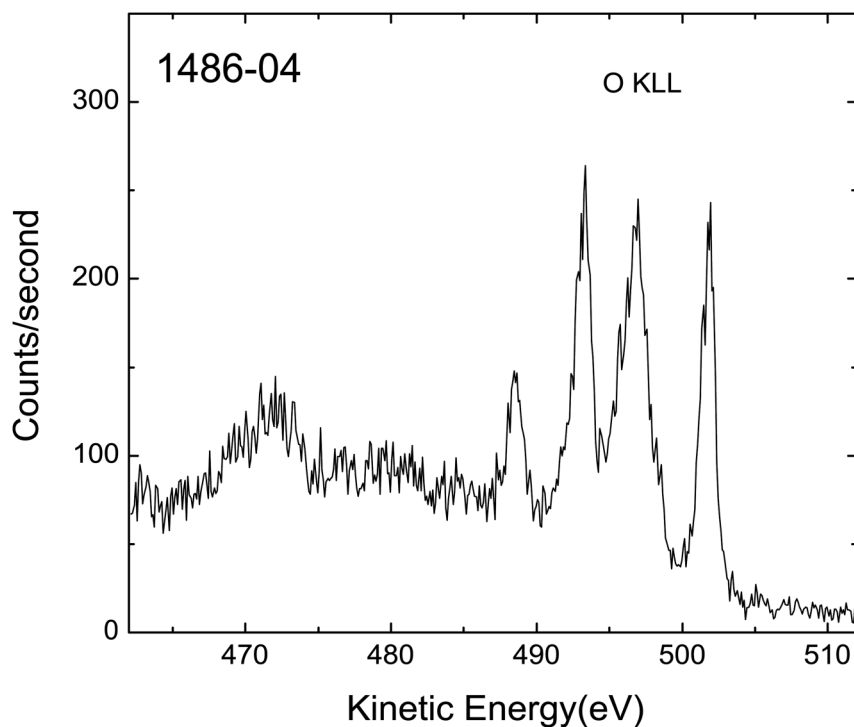




■ **Accession #:** 01486-03
 ■ **Host Material:** Carbon dioxide, CO₂(g)
 ■ **Technique:** XPS
 ■ **Spectral Region:** C 1s

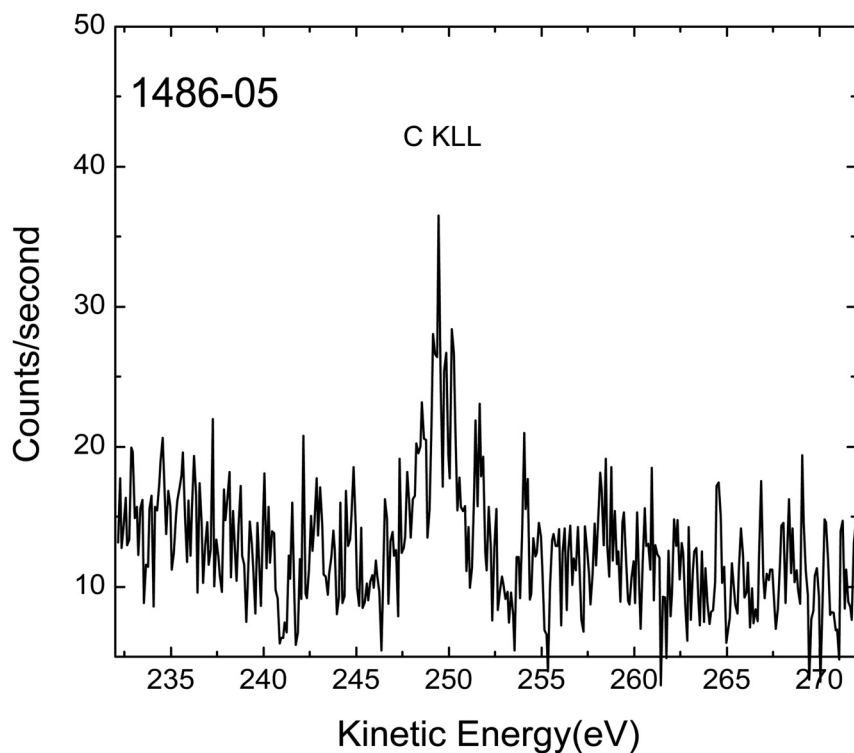
Instrument: SPECS EnviroESCA
 Excitation Source: Al K_α monochromatic
 Source Energy: 1486.6 eV
 Source Strength: 42 W
 Source Size: 0.250 × 0.250 mm²
 Analyzer Type: Spherical sector
 Incident Angle: 54.7°
 Emission Angle: 0°
 Analyzer Pass Energy: 20 eV
 Analyzer Resolution: 0.60 eV
 Total Signal Accumulation Time: 270 s
 Total Elapsed Time: 303 s
 Number of Scans: 3
 Effective Detector Width: 2.5 eV





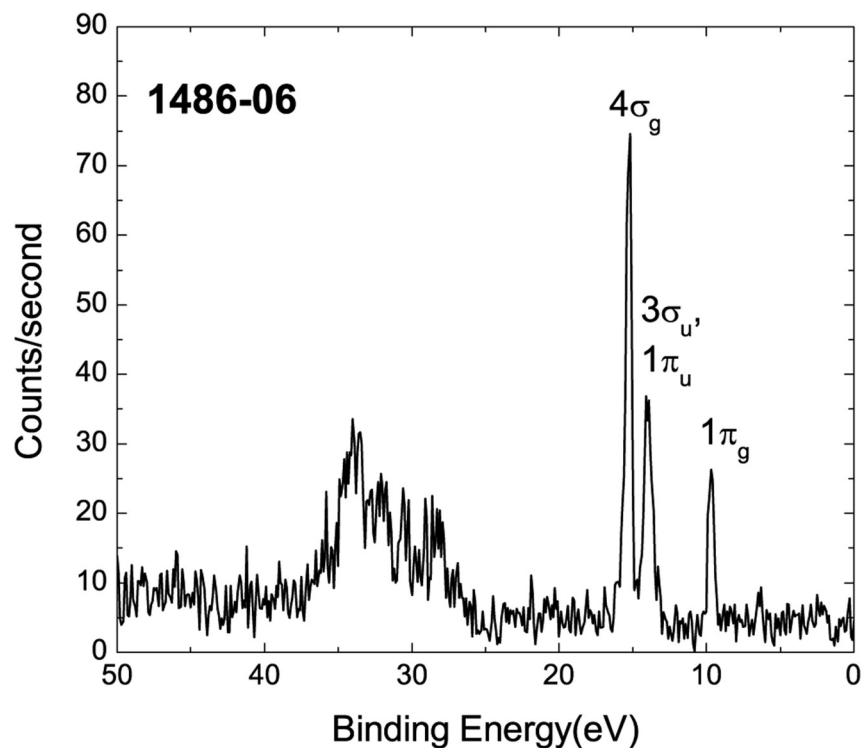
■ **Accession #:** 01486-04
 ■ **Host Material:** Carbon dioxide, CO₂(g)
 ■ **Technique:** XAES
 ■ **Spectral Region:** O KLL

Instrument: SPECS EnviroESCA
 Excitation Source: Al K_α monochromatic
 Source Energy: 1486.6 eV
 Source Strength: 42 W
 Source Size: 0.250 × 0.250 mm²
 Analyzer Type: Spherical sector
 Incident Angle: 54.7°
 Emission Angle: 0°
 Analyzer Pass Energy: 20 eV
 Analyzer Resolution: 0.60 eV
 Total Signal Accumulation Time: 400 s
 Total Elapsed Time: 445 s
 Number of Scans: 4
 Effective Detector Width: 2.5 eV



■ **Accession #:** 01486-05
 ■ **Host Material:** Carbon dioxide, CO₂(g)
 ■ **Technique:** XAES
 ■ **Spectral Region:** C KLL

Instrument: SPECS EnviroESCA
 Excitation Source: Al K_α monochromatic
 Source Energy: 1486.6 eV
 Source Strength: 42 W
 Source Size: 0.250 × 0.250 mm²
 Analyzer Type: Spherical sector
 Incident Angle: 54.7°
 Emission Angle: 0°
 Analyzer Pass Energy: 20 eV
 Analyzer Resolution: 0.60 eV
 Total Signal Accumulation Time: 320 s
 Total Elapsed Time: 363 s
 Number of Scans: 4
 Effective Detector Width: 2.5 eV



■ **Accession #:** 01486-06
■ **Host Material:** Carbon dioxide, CO₂(g)
■ **Technique:** XPS
■ **Spectral Region:** O 2s and Valence band

Instrument: SPECS EnviroESCA
Excitation Source: Al K_α monochromatic
Source Energy: 1486.6 eV
Source Strength: 42 W
Source Size: 0.250 × 0.250 mm²
Analyzer Type: Spherical sector
Incident Angle: 54.7°
Emission Angle: 0°
Analyzer Pass Energy: 20 eV
Analyzer Resolution: 0.60 eV
Total Signal Accumulation Time: 416 s
Total Elapsed Time: 461 s
Number of Scans: 4
Effective Detector Width: 2.5 eV